FCC
RF Test Report

Product Name: Smart Phone

Model Number: MRD-LX1

Report No.: SYBH(Z-RF)20181011024001-2001

FCC ID：QISMRD-LX1

Autheorized	APPROVED (Lab Manager)	PREPARED (Test Engineer)
BY	He Hao	Maowenli
DATE	2018-12-24	2018-12-24

Reliability Laboratory of Huawei Technologies Co., Ltd.

(Global Compliance and Testing Center of Huawei Technologies Co., Ltd)

Administration Building, Headquarters of Huawei Technologies Co., Ltd., Bantian, Longgang District, Shenzhen, 518129, P.R.C

Tel: +86 755 28780808 Fax: +86 755 89652518

※ ※ Notice ※ ※

1. The Reliability Laboratory of Huawei Technologies Co., Ltd has passed the accreditation by The American Association for Laboratory Accreditation (A2LA). The accreditation number is 2174.01

2. The Laboratory of Sporton International (Shenzhen) Inc has passed the accreditation by National Voluntary Laboratory Accreditation Program (NVLAP). The NVLAP LAB CODE is 600156-0.

3. The Reliability Laboratory of Huawei Technologies Co., Ltd has been recognized by the US Federal Communications Commission (FCC) to perform compliance testing subject to the Commission's Certification rules. The Designation Number is CN1173, and the Test Firm Registration Number is 294140.

4. The Laboratory of Sporton International (Shenzhen) Inc has been recognized by the US Federal Communications Commission (FCC) to perform compliance testing subject to the Commission's Certification rules. The Designation Number is CN5019, and the Test Firm Registration Number is 577730.

5. The Reliability Laboratory of Huawei Technologies Co., Ltd has been listed by Industry Canada to perform electromagnetic emission measurements. The recognition numbers of test site are 6369A-1.

6. The Reliability Laboratory of Huawei Technologies Co., Ltd is also named “Global Compliance and Testing Center of Huawei Technologies Co., Ltd”, the both names have coexisted since 2009.

7. The test report is invalid if not marked with the signatures of the persons responsible for preparing and approving the test report.

8. The test report is invalid if there is any evidence of erasure and/or falsification.

9. The test report is only valid for the test samples.

10. Content of the test report, in part or in full, cannot be used for publicity and/or promotional purposes without prior written approval from the laboratory.

MODIFICATION RECORD

No.	Report No	Modification Description
1	SYBH(Z-RF)20181011024001	First release.

DECLARATION

Type	Description
Multiple Models Applications	☒ The present report applies to single model. ☐ The present report applies to several models. The practical measurements are performed with the model. The present report only presents the worst test case of all modes, see relevant test results for detailed.

1 Table of contents

2 General Information

2.1 Test standard/s

Applied Rules :	47 CFR FCC Part 02 47 CFR FCC Part 22 47 CFR FCC Part 24 47 CFR FCC Part 27
Test Method :	FCC KDB 971168 D01 Power Meas License Digital Systems v03r01 ANSI C63.26

2.2 Test Environment

Temperature :	TN	15 to 30	°C during room temperature tests
Ambient Relative Humidity:	20 to 85 %		
Atmospheric Pressure:	Not applicable		
Power supply :	VL	3.6 V	
	VN	3.82 V	DC by Battery
	VH	4.4 V	

NOTE 1: 1) VN= nominal voltage, VL= low extreme test voltage, VH= High extreme test voltage;

TN= normal temperature, TL= low extreme test temperature, TH= High extreme test temperature.

NOTE 2: The values used in the test report may be stringent than the declared.

2.3 Test Laboratories

Test Location 1 :	RELIABILITY LABORATORY OF HUAWEI TECHNOLOGIES CO., LTD.
Address of Test Location 1 :	No.2 New City Avenue Songshan Lake Sci. &Tech. Industry Park, Dongguan, Guangdong, P.R.C
Sub-contracted Test Location 1 :	Sporton International (Shenzhen) Inc.
Address of Sub-contracted Test Location 1 :	No.3 Building, the third floor of south, Shahe River west, Fengzeyuan warehouse, Nanshan District, Shenzhen, Guangdong, P.R.China

2.4 Applicant and Manufacturer

Company Name :	HUAWEI TECHNOLOGIES CO., LTD
Address :	Administration Building, Headquarters of Huawei Technologies Co., Ltd., Bantian, Longgang District, Shenzhen, 518129, P.R.C

2.5 Application details

Date of Receipt Sample:	2018-12-04
Start of test:	2018-12-05
End of test:	2018-12-24

3 Test Summary

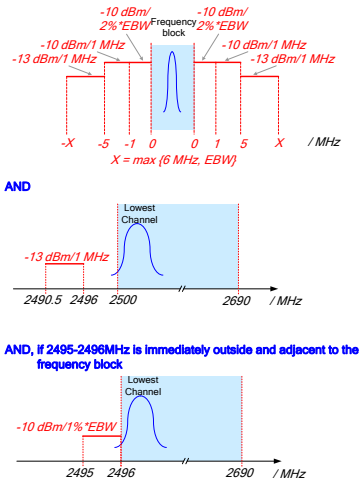
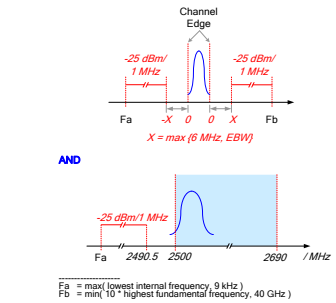
3.1 Cellular Band (824-849 MHz paired with 869-894 MHz)

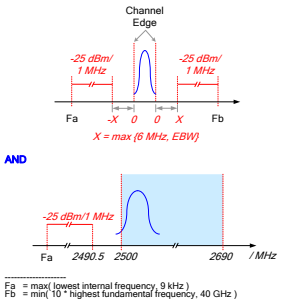
Test Item	FCC Rule No.	Requirements	Test Result	Verdict (Note1)	Testing location
Effective (Isotropic) Radiated Power Output Data	§2.1046, §22.913	FCC: ERP ≤ 7 W	Appendix A	Pass	Test Location 1
Peak-Average Ratio	---	Limit≤13 dB	Appendix B	Pass	Test Location 1
Modulation Characteristics	§2.1047	Digital modulation	Appendix C	Pass	Test Location 1
Bandwidth	§2.1049	OBW: No limit. EBW: No limit.	Appendix D	Pass	Test Location 1
Band Edges Compliance	§2.1051, §22.917	FCC: ≤ -13 dBm/1%*EBW, in 1 MHz bands immediately outside and adjacent to the frequency block. _____ Note 1): EBW is -26 dBc EBW.	Appendix E	Pass	Test Location 1
Spurious Emission at Antenna Terminals	§2.1051, §22.917	FCC: ≤ -13 dBm/RefBW, from max(lowest internal frequency, 9 kHz) to min(10 * highest fundamental frequency, 40 GHz), after 1 MHz bands immediately outside and adjacent to the frequency block. (RefBW: ≥100 kHz for frequency below 1 GHz, and =1 MHz above 1 GHz)	Appendix F	Pass	Test Location 1
Field Strength of Spurious Radiation	§2.1053, §22.917	FCC: ≤ -13 dBm/RefBW, from max(lowest internal frequency, 9 kHz) to min(10 * highest fundamental frequency, 40 GHz), after 1 MHz bands immediately outside and adjacent to the frequency block. (RefBW: ≥100 kHz for frequency below 1 GHz, and =1 MHz above 1 GHz)	Appendix G	Pass	Test Location 1(above 30MHz); Sub-contracted Test Location 1 (9K-30MHz)
Frequency Stability	§2.1055, §22.355	≤ ±2.5ppm	Appendix H	Pass	Test Location 1
NOTE: For the verdict, the “N/A” denotes “not applicable”, the “N/T” denotes “not tested”.					

3.2 PCS Band (1850-1910 MHz paired with 1930-1990 MHz)

Test Item	FCC Rule No.	Requirements	Test Result	Verdict （Note1）	Testing location
Effective (Isotropic) Radiated Power Output Data	§2.1046, §24.232	EIRP ≤ 2 W	Appendix A	Pass	Test Location 1
Peak-Average Ratio	§2.1046, §24.232	Limit≤13 dB	Appendix B	Pass	Test Location 1
Modulation Characteristics	§2.1047	Digital modulation	Appendix C	Pass	Test Location 1
Bandwidth	§2.1049	OBW: No limit. EBW: No limit.	Appendix D	Pass	Test Location 1
Band Edges Compliance	§2.1051, §24.238	≤ -13 dBm/1%*EBW, in 1 MHz bands immediately outside and adjacent to the frequency block. _____ Note 1): EBW is -26 dBc EBW.	Appendix E	Pass	Test Location 1
Spurious Emission at Antenna Terminals	§2.1051, §24.238	≤ -13 dBm/1 MHz, from max(lowest internal frequency, 9 kHz) to min(10 * highest fundamental frequency, 40 GHz) but outside authorized operating frequency blocks.	Appendix F	Pass	Test Location 1
Field Strength of Spurious Radiation	§2.1053, §24.238	≤ -13 dBm/1 MHz, from max(lowest internal frequency, 9 kHz) to min(10 * highest fundamental frequency, 40 GHz) but outside authorized operating frequency blocks.	Appendix G	Pass	Test Location 1(above 30MHz); Sub-contracted Test Location 1 (9K-30MHz)
Frequency Stability	§2.1055, §24.235	Within authorized bands of operation/frequency block.	Appendix H	Pass	Location 1
NOTE: For the verdict, the “N/A” denotes “not applicable”, the “N/T” denotes “not tested”.					

3.3 BRS&EBS Band (2500-2570 MHz paired with 2620-2690 MHz)

Test Item	FCC Rule No.	Requirements	Test Result	Verdict (Note1)	Testing location
Effective (Isotropic) Radiated Power Output Data	§2.1046, §27.50(h)	EIRP ≤ 2W	Appendix A	Pass	Test Location 1
Peak-Average Ratio	§27.50(a)	Limit≤13 dB	Appendix B	Pass	Test Location 1
Modulation Characteristics	§2.1047	Digital modulation	Appendix C	Pass	Test Location 1
Bandwidth	§2.1049	OBW: No limit. EBW: No limit.	Appendix D	Pass	Test Location 1
Band Edges Compliance	§2.1051, §27.53(m4)	FCC:  Note 1): EBW is -26 dBc EBW.	Appendix E	Pass	Test Location 1
Spurious Emission at Antenna Terminals	§2.1051, §27.53(m)	FCC:  Note 1): EBW is -26 dBc EBW.	Appendix F	Pass	Test Location 1

Test Item	FCC Rule No.	Requirements	Test Result	Verdict （Note1）	Testing location
		Note 2): MeasFrom: max(lowest internal frequency, 9 kHz). Note 3): MeasTo: min(10 * highest fundamental frequency, 40 GHz).			
Field Strength of Spurious Radiation	§2.1053, §27.53(m)	FCC:  Note 1): EBW is -26 dBc EBW. Note 2): MeasFrom: max(lowest internal frequency, 9 kHz). Note 3): MeasTo: min(10 * highest fundamental frequency, 40 GHz).	Appendix G	Pass	Location 1(above 30MHz); Sub-contracted Test Location 1 (9K-30MHz)
Frequency Stability	§2.1055, §27.54	Within authorized bands of operation/frequency block.	Appendix H	Pass	Test Location 1
NOTE: For the verdict, the “N/A” denotes “not applicable”, the “N/T” denotes “not tested”.					

4 Description of the Equipment under Test (EUT)

4.1 General Description

MRD-LX1 is subscriber equipment in the GSM/WCDMA/LTE system. The GSM frequency bands include GSM850, GSM900, DCS1800 and PCS1900. The UMTS frequency band includes band I, band II, band V and band VIII. The LTE frequency bands include band 1, band 3, band 5, band 7, band 8, band 20. The Mobile Phone implements such functions as RF signal receiving/transmitting, LTE/HSPA/UMTS and GSM/GPRS/EDGE protocol processing, voice, video MMS service, GPS, AGPS and WIFI etc. Externally it provides one micro SD card interface, earphone port (to provide voice service), and dual SIM card interface. MRD-LX1 is dual SIM smart phone. It also provides Bluetooth module to synchronize data between a PC and the phone, or to use the built-in modem of the phone to access the Internet with a PC, or to exchange data with other Bluetooth devices.
Note: Only GSM GSM850 and GSM1900, UMTS B2 and B5, LTE B5 and B7 test data included in this report.

4.2 EUT Identity

NOTE: Unless otherwise noted in the report, the functional boards installed in the units shall be selected from the below list, but not means all the functional boards listed below shall be installed in one unit.

4.2.1Board

Board		
Description	Hardware Version	Software Version
Main Board	HL1JATM	5.0.1.57（SP1C900E64R1P3）

4.2.2 Sub-Assembly

Sub-Assembly			
Sub-Assembly Name	Model	Manufacturer	Description
Adapter	HW-050100U01	Huawei Technologies Co., Ltd.	Input Voltage: 100V-240V Output Voltage: 5V ⎓ 1A
Li-ion Battery	HB405979ECW	Huawei Technologies Co., Ltd.	Rated capacity: 2920mAh Nominal Voltage: ⎓ +3.82V Charging Voltage: ⎓ +4.40V

4.3 Technical Specification

NOTE: For the detailed technical descriptions, see the applicant/manufacturer's specifications or user manual.

Characteristics	Description	
Radio System Type	☒ GSM ☒ UMTS ☒ LTE	
Supported Frequency Range	GSM850/ WCDMA850	Transmission (TX): 824 to 849 MHz
		Receiving (RX): 869 to 894 MHz
	PCS1900/ WCDMA1900	Transmission (TX): 1850 to 1910 MHz
		Receiving (RX): 1930 to 1990 MHz
	LTE BAND5	Transmission (TX): 824 to 849 MHz
		Receiving (RX): 869 to 894 MHz
	LTE BAND7	Transmission (TX): 2500 to 2570 MHz
		Receiving (RX): 2620 to 2690 MHz
Antenna	Description	Isotropic Antenna
	Type	☒ Integral ☐ External ☐ Dedicated
	TX and RX Antenna Ports(one band)	TX & RX port: 1 TX-only port: 0 RX-only port: 1
	Smart Antenna(for uplink)	☐ MIMO ☒ Non MIMO
	Gain	GSM850: -2.1 dBi (per antenna port, max) PCS1900: 1.1 dBi (per antenna port, max) WCDMA 850: -2.1 dBi (per antenna port, max) WCDMA 1900: 1.1 dBi (per antenna port, max) LTE Band 5: -2.1 dBi (per antenna port, max) LTE Band 7: -1 dBi (per antenna port, max)
	Remark	When the EUT is put into service, the practical maximum antenna gain should NOT exceed the value as described above.
Target TX Output Power	GSM850: 33 dBm GSM1900: 30 dBm UMTS850: 24 dBm UMTS1900: 23.5 dBm LTE Band 5: 23.5 dBm LTE Band 7: 23.0 dBm	
Supported Channel Bandwidth	GSM system:	☒ 200 kHz
	UMTS system:	☒ 5 MHz

Characteristics	Description	
	LTE band 5	☒1.4MHz, ☒3MHz, ☒5MHz, ☒10MHz
	LTE band 7	☒5MHz, ☒10MHz ,☒15MHz ,☒20MHz
Type of Modulation for uplink	GSM	☒ GMSK ☒ 8PSK
	WCDMA	☒ QPSK ☒ 16QAM(only for HSPA+) ☐ 64QAM
	LTE	☒ QPSK ☒ 16QAM ☐ 64QAM
Designation of Emissions (Note: the necessary bandwidth of which is the worst value from the measured occupied bandwidths for each type of channel bandwidth configuration.)	GSM850:	245KGXW, 252KG7W
	GSM1900:	247KGXW, 248KG7W
	UMTS850:	4M18F9W
	UMTS1900:	4M18F9W
	LTE BAND5:	1M10G7D (1.4 MHz QPSK modulation), 1M09W7D (1.4 MHz 16QAM modulation) 2M69G7D (3 MHz QPSK modulation), 2M69W7D (3 MHz 16QAM modulation) 4M51G7D (5 MHz QPSK modulation), 4M51W7D (5 MHz 16QAM modulation) 9M00G7D (10 MHz QPSK modulation), 9M01W7D (10 MHz 16QAM modulation)
	LTE BAND7:	4M52G7D (5 MHz QPSK modulation), 4M49W7D (5 MHz 16QAM modulation) 8M99G7D (10 MHz QPSK modulation), 9M00W7D (10 MHz 16QAM modulation) 13M5G7D (15 MHz QPSK modulation), 13M5W7D (15 MHz 16QAM modulation) 18M0G7D (20 MHz QPSK modulation), 18M0W7D (20 MHz 16QAM modulation)
Power Supply	Type	☐ External DC mains, ☒ Battery, ☐ AC/DC Adapter, ☐ Powered over Ethernet (PoE). ☐ Other

5 General Test Conditions / Configurations

5.1 Test Modes

NOTE1: The test mode(s) are selected according to relevant radio technology specifications.
NOTE2: The modulation for WCDMA, HSUPA, HSDPA, DC-HSDPA is the same, which is QPSK, and the WCDMA is the worst, so we test the WCDMA only.
NOTE3: The power of HSPA+ system with 16QAM modulation is lower than that of QPSK, so we did not test 16QAM modulation.

Test Mode	Test Modes Description
GSM/TM1	GSM system, GSM/GPRS, GMSK modulation
GSM/TM2	GSM system, EDGE, 8PSK modulation
UMTS/TM1	WCDMA system, QPSK modulation
LTE/TM1	LTE system, QPSK modulation
LTE/TM2	LTE system, 16QAM modulation

5.2 Test Frequency

Test Mode	TX / RX	RF Channel		
		Low (L)	Middle (M)	High (H)
GSM850	TX	Channel 128	Channel 190	Channel 251
		824.2MHz	836.6MHz	848.8MHz
	RX	Channel 128	Channel 190	Channel 251
		869.2MHz	881.6MHz	893.8MHz
WCDMA850	TX	Channel 4132	Channel 4182	Channel 4233
		826.4MHz	836.4MHz	846.6MHz
	RX	Channel 4357	Channel 4407	Channel 4458
		871.4MHz	881.4MHz	891.6MHz
Test Mode	TX / RX	RF Channel		
		Low (L)	Middle (M)	High (H)
GSM1900	TX	Channel 512	Channel 661	Channel 810
		1850.2MHz	1880.0MHz	1909.8MHz
	RX	Channel 512	Channel 661	Channel 810
		1930.2 MHz	1960.0 MHz	1989.8 MHz
WCDMA1900	TX	Channel 9262	Channel9400	Channel9538
		1852.4MHz	1880.0MHz	1907.6MHz
	RX	Channel 9662	Channel 9800	Channel 9938
		1932.4 MHz	1960.0 MHz	1987.6 MHz
Test Mode	TX / RX	RF Channel		
		Low (L)	Middle (M)	High (H)

Test Mode	TX / RX	RF Channel		
		Low (B)	Middle (M)	High (T)
LTE Band 5	TX(1.4M)	Channel 20407	Channel 20525	Channel 20643
		824.7 MHz	836.5 MHz	848.3 MHz
	TX(3M)	Channel 20415	Channel 20525	Channel 20635
		825.5 MHz	836.5 MHz	847.5 MHz
	TX(5M)	Channel 20425	Channel 20525	Channel 20625
		826.5 MHz	836.5 MHz	846.5 MHz
	TX(10M)	Channel 20450	Channel 20525	Channel 20600
		829 MHz	836.5 MHz	844 MHz
	RX(1.4M)	Channel 2407	Channel 2525	Channel 2643
		869.7 MHz	881.5 MHz	893.3 MHz
	RX (3M)	Channel 2415	Channel 2525	Channel 2635
		870.5 MHz	881.5 MHz	892.5 MHz
	RX(5M)	Channel 2425	Channel 2525	Channel 2625
		871.5 MHz	881.5 MHz	891.5 MHz
	RX (10M)	Channel 2450	Channel 2525	Channel 2600
		874 MHz	881.5 MHz	889 MHz

Test Mode	TX / RX	RF Channel		
		Low (B)	Middle (M)	High (T)
LTE Band 7	TX (5M)	Channel 20775	Channel 21100	Channel 21425
		2502.5 MHz	2535 MHz	2567.5 MHz
	TX (10M)	Channel 20800	Channel 21100	Channel 21400
		2505 MHz	2535 MHz	2565 MHz
	TX (15M)	Channel 20825	Channel 21100	Channel 21375

Test Mode	TX / RX	RF Channel		
		Low (B)	Middle (M)	High (T)
		2507.5 MHz	2535 MHz	2562.5 MHz
	TX (20M)	Channel 20850	Channel 21100	Channel 21350
		2510 MHz	2535 MHz	2560 MHz
	RX (5M)	Channel 2775	Channel 3100	Channel 3425
		2622.5 MHz	2655 MHz	2687.5 MHz
	RX (10M)	Channel 2800	Channel 3100	Channel 3400
		2625 MHz	2655 MHz	2685 MHz
	RX (15M)	Channel 2825	Channel 3100	Channel 3375
		2627.5 MHz	2655 MHz	2682.5 MHz
	RX (20M)	Channel 2850	Channel 3100	Channel 3350
		2630 MHz	2655 MHz	2680 MHz

5.3 DESCRIPTION OF TESTS

5.3.1 Radiated Power and Radiated Spurious Emissions

Radiated spurious emissions are investigated indoors in a full-anechoic chamber to determine the frequencies producing the worst case emissions. Final measurements for radiated power and radiated spurious emissions are performed on the 3 meter OATS per the guidelines of ANSI/TIA-603-E-2016. The equipment under test was transmitting while connected to its integral antenna and is placed on a wooden turntable 150cm above the ground plane and 3 meters from the receive antenna. The spectrum is scanned from the lowest frequency generated in the equipment up to a frequency including its 10th harmonic. The receive antenna height is adjusted between 1 and 4 meter height, the turntable is rotated through 360 degrees, and the EUT is manipulated through all orthogonal planes representative of its typical use to achieve the highest reading on the receive spectrum analyzer. Emissions are also investigated with the receive antenna horizontally and vertically polarized.

A portable or small unlicensed wireless device shall be placed on a non-metallic test fixture or other non-metallic support during testing. The supporting fixture shall permit orientation of the EUT in each of three orthogonal (x, y, z) axis positions such that emissions from the EUT are maximized. Measure the EUT maximum RF power and record the result.

A half-wave dipole is then substituted in place of the EUT. For emissions above 3GHz, a horn antenna is substituted in place of the EUT. The substitute antenna is driven by a signal generator with the level of the signal generator being adjusted to obtain the same receive spectrum analyzer level previously recorded from the spurious emission from the EUT.

The power of the emission is calculated using the following formula:

$$P_{d\ [dBm]} = P_{g\ [dBm]} - \text{cable loss}_{\ [dB]} + \text{antenna gain}_{\ [dBd/dBi]}$$

Where, P_d is the dipole equivalent power, P_g is the generator output into the substitution antenna, and the antenna gain is the gain of the substitute antenna used relative to either a half-wave dipole (dBd) or an isotropic source (dBi). The substitute level is equal to Pg [dBm] – cable loss [dB].

The calculated Pd levels are then compared to the absolute spurious emission limit of -13dBm which is equivalent to the required minimum attenuation of $43 + 10\log_{10}(\text{Power}_{[\text{Watts}]})$.

Test Procedures Used

KDB 971168 D01 v03-Section 5

ANSI/TIA-603-E-2016-Section 2.2.17 / ANSI/TIA-603-E-2016-Section 2.2.12

Note: Reference test setup 3

5.3.2 Peak-Average Ratio

A peak to average ratio measurement is performed at the conducted port of the EUT. The spectrum analyzers Complementary Cumulative Distribution Function (CCDF) measurement profile is used to determine the largest deviation between the average and the peak power of the EUT in a given bandwidth.

Test Procedures Used

KDB 971168 D01 v03-Section 5.7.2

Test Settings

1、The signal analyzer's CCDF measurement profile enabled

2、Frequency= carrier center frequency

3、Measurement BW > EBW of signal

4、for continuous transmissions, set to 1ms

5、Record the maximum PAPR level associated with a probability of 0.1%.

Note: Reference test setup 1

5.3.3 Occupied Bandwidth

The occupied bandwidth, that is the frequency bandwidth such that, below its lower and above its upper frequency limits, the mean powers radiated are each equal to 0.5 percent of the total mean power radiated by a given emission shall be measured. The span of the analyzer shall be set to capture all products of the modulation process, including the emission skirts. The resolution bandwidth shall be set to as close to 1 percent of the selected span as is possible without being below 1 percent. The video bandwidth shall be set to 3 times the resolution bandwidth. Video averaging is not permitted. Where practical, a sampling detector shall be used since a peak or, peak hold, may produce a wider bandwidth than actual. The trace data points are recovered and are directly summed in linear terms. The recovered amplitude data points, beginning at the lowest frequency, are placed in a running sum until 0.5 percent of the total is reached and that frequency recorded. The process is repeated for the highest frequency data points. This frequency is recorded. The span between the two recorded frequencies is the occupied bandwidth.

Test Procedures Used

KDB 971168 D01 v03-Section 4.3

Test Settings

1、SET RBW=1-5% of OBW

2、SET VBW ≥ 3*RBW

3、Detector: Peak

4、Trace mode= max hold.

5、Sweep= auto couple

6、Steps 1-5 were repeated after it is stable

Note: Reference test setup 1.

5.3.4 Band Edge Compliance

The test complies with the requirements in clause 2 of the present report according to test procedures in KDB 971168 D01 v03-Section 6 with corresponding test settings.

Note: Reference test setup 1.

5.3.5 Spurious and Harmonic Emissions at Antenna Terminal

The test complies with the requirements in clause 2 of the present report according to test procedures in KDB 971168 D01 v03-Section 6 with corresponding test settings.

Note: Reference test setup 1.

5.3.6 Frequency Stability / Temperature Variation

Frequency stability testing is performed in accordance with the guidelines of ANSI/TIA-603-E-2016. The frequency stability of the transmitter is measured by:

a.) **Temperature:** The temperature is varied from -30°C to +50°C in 10°C increments using an environmental chamber.

b.) **Primary Supply Voltage:** The primary supply voltage is varied from 85% to 115% of the nominal value for non hand-carried battery and AC powered equipment. For hand-carried, battery-powered equipment, primary supply voltage is reduced to the battery operating end point which shall be specified by the manufacturer.

Specification – The frequency stability shall be sufficient to ensure that the fundamental emission stays within the authorized frequency block. The frequency stability of the transmitter shall be maintained within ±0.00025% (±2.5 ppm) of the center frequency.

Time Period and Procedure:

1. The carrier frequency of the transmitter is measured at room temperature (20°C to provide a reference).
2. The equipment is turned on in a “standby” condition for fifteen minutes before applying power to the transmitter. Measurement of the carrier frequency of the transmitter is made within one minute after applying power to the transmitter.
3. Frequency measurements are made at 10°C intervals ranging from -30°C to +50°C. A period of at least one half-hour is provided to allow stabilization of the equipment at each temperature level.

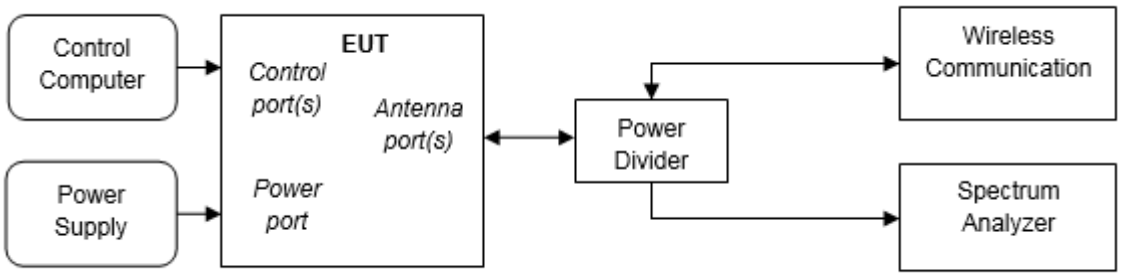
Test Procedures Used

ANSI/TIA-603-E-2016

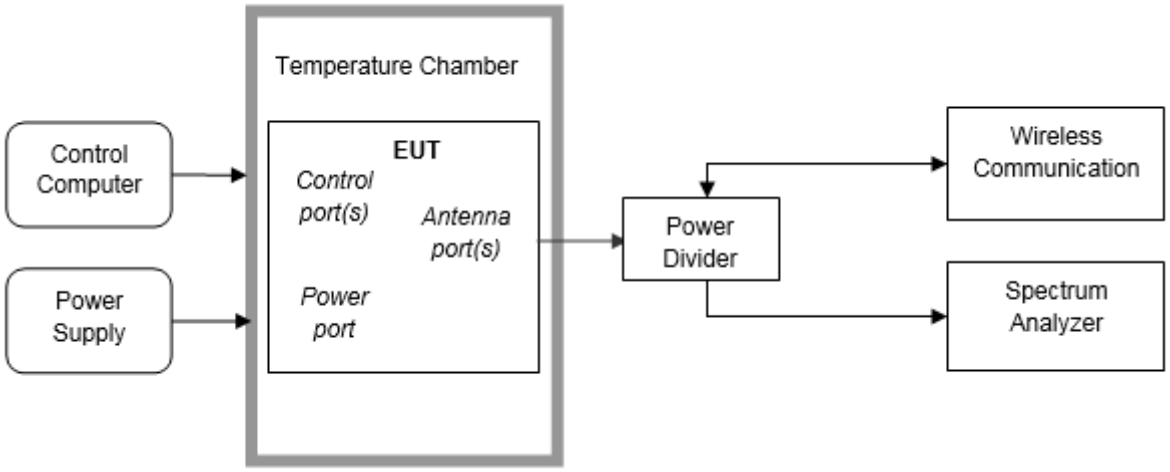
Note: Reference test setup 2.

5.4 Test Setups

5.4.1 Test Setup 1



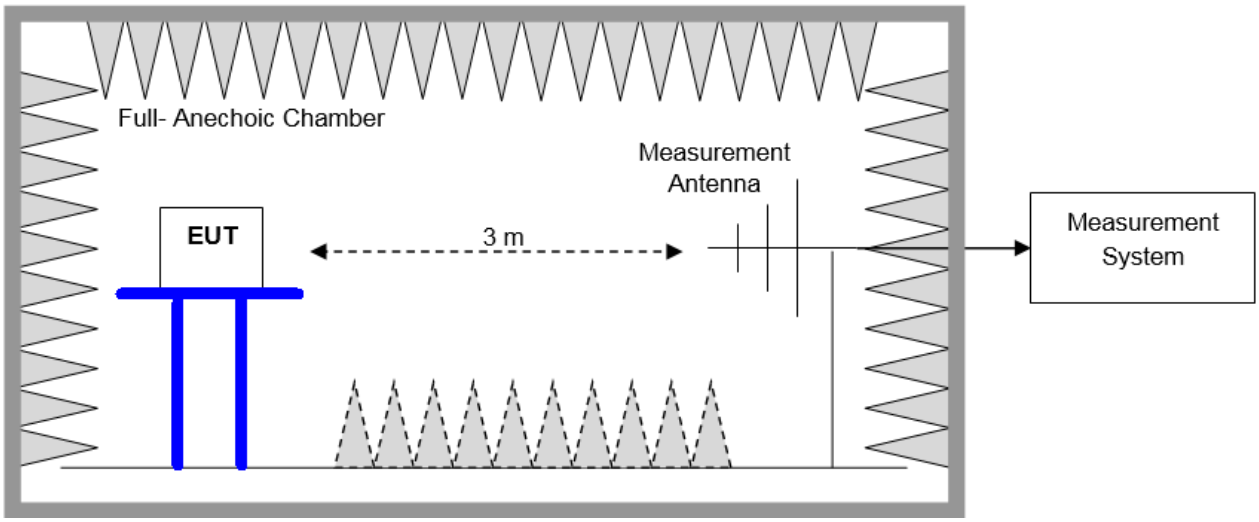
5.4.2 Test Setup 2



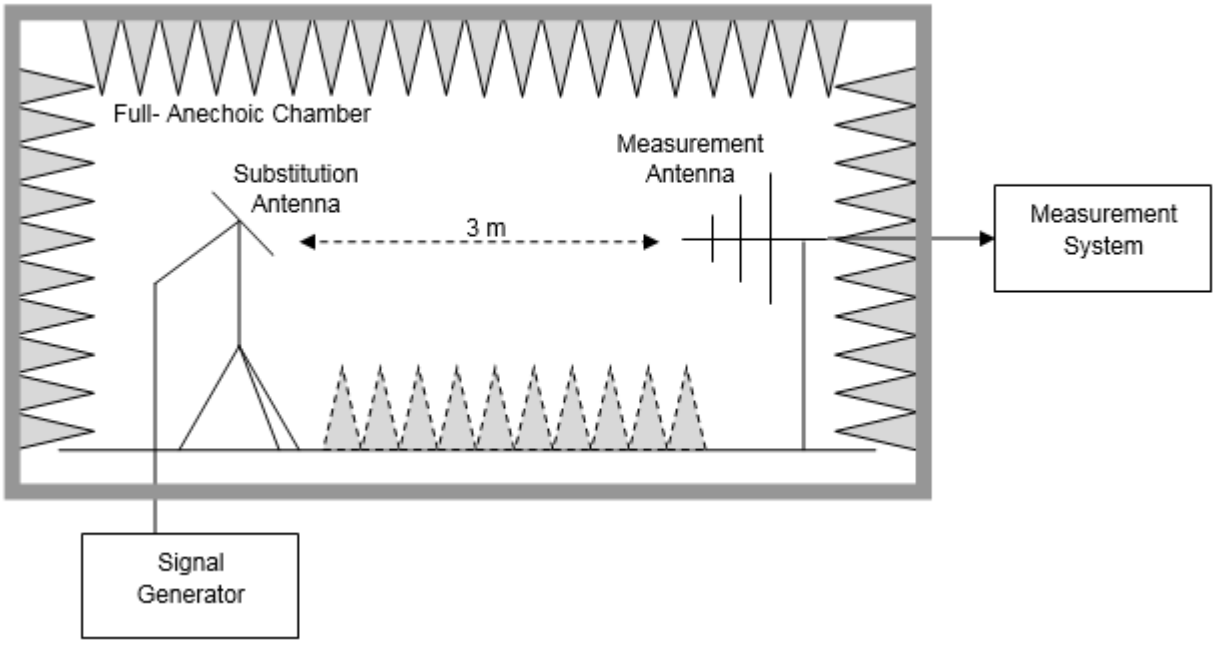
5.4.3 Test Setup 3

NOTE: Effective radiated power (ERP) and Equivalent Isotropic Radiated Power(EIRP) refers to the radiation power output of the EUT, assuming all emissions are radiated from half-wave dipole antennas.

5.4.3.1 Step 1: Pre-test



5.4.3.2 Step 2: Substitution method to verify the maximum ERP/EIRP



5.5 Test Conditions

Test Case		Test Conditions	
Transmit Output Power Data	Average Power, Total	Test Env.	Ambient Climate & Rated Voltage
		Test Setup	Test Setup 1
		RF Channels (TX)	L, M, H (L= low channel, M= middle channel, H= high channel)
		Test Mode	GSM/TM1,GSM/TM2,UMTS/TM1,LTE/TM1,LTE/TM2
	Average Power, Spectral Density (if required)	Test Env.	Ambient Climate & Rated Voltage
		Test Setup	Test Setup 1
		RF Channels (TX)	L, M, H (L= low channel, M= middle channel, H= high channel)
		Test Mode	GSM/TM1,GSM/TM2,UMTS/TM1,LTE/TM1,LTE/TM2
Peak-to-Average Ratio (if required)		Test Env.	Ambient Climate & Rated Voltage
		Test Setup	Test Setup 1
		RF Channels (TX)	L, M, H (L= low channel, M= middle channel, H= high channel)
		Test Mode	GSM/TM1,GSM/TM2,UMTS/TM1,LTE/TM1,LTE/TM2
Modulation Characteristics		Test Env.	Ambient Climate & Rated Voltage
		Test Setup	Test Setup 1
		RF Channels (TX)	M (L= low channel, M= middle channel, H= high channel)
		Test Mode	GSM/TM1,GSM/TM2,UMTS/TM1,LTE/TM1,LTE/TM2
Bandwidth	Occupied Bandwidth	Test Env.	Ambient Climate & Rated Voltage
		Test Setup	Test Setup 1
		RF Channels (TX)	L, M, H (L= low channel, M= middle channel, H= high channel)
		Test Mode	GSM/TM1,GSM/TM2,UMTS/TM1,LTE/TM1,LTE/TM2
	Emission Bandwidth (if required)	Test Env.	Ambient Climate & Rated Voltage
		Test Setup	Test Setup 1
		RF Channels (TX)	L, M, H (L= low channel, M= middle channel, H= high channel)
		Test Mode	GSM/TM1,GSM/TM2,UMTS/TM1,LTE/TM1,LTE/TM2
Band Edges Compliance		Test Env.	Ambient Climate & Rated Voltage
		Test Setup	Test Setup 1
		RF Channels (TX)	L, H (L= low channel, M= middle channel, H= high channel)
		Test Mode	GSM/TM1,GSM/TM2,UMTS/TM1,LTE/TM1,LTE/TM2
Spurious Emission at Antenna Terminals		Test Env.	Ambient Climate & Rated Voltage
		Test Setup	Test Setup 1
		RF Channels (TX)	L, M, H (L= low channel, M= middle channel, H= high channel)

Test Case	Test Conditions	
	Test Mode	GSM/TM1,GSM/TM2,UMTS/TM1,LTE/TM1,LTE/TM2
Field Strength of Spurious Radiation	Test Env.	Ambient Climate & Rated Voltage
	Test Setup	Test Setup 3
	Test Mode	GSM/TM1,GSM/TM2,UMTS/TM1/TM2/TM3,LTE/TM1,LTE/TM2 NOTE: If applicable, the EUT conf. that has maximum power density (based on the equivalent power level) is selected.
	RF Channels (TX)	L, M, H (L= low channel, M= middle channel, H= high channel)
Frequency Stability	Test Env.	(1) -30 °C to +50 °C with step 10 °C at Rated Voltage; (2) VL, VN and VH of Rated Voltage at Ambient Climate.
	Test Setup	Test Setup 2
	RF Channels (TX)	L, M, H (L= low channel, M= middle channel, H= high channel)
	Test Mode	GSM/TM1,GSM/TM2,UMTS/TM1,LTE/TM1,LTE/TM2

6 Main Test Instruments

6.1.1 Test Location 1:

This table gives a complete overview of the RF measurement equipment.

Devices used during the test described are marked ☒

☒ Main Test Equipments(GSM/WCDMA/LTE test system)						
Marked	Equipment Name	Manufacturer	Model	Serial Number	Cal Date	Cal-Due
☐	DC Power Supply	KEITHLEY	2303	1342889	2018/10/24	2019/10/24
☐	DC Power Supply	KEITHLEY	2303	000500E	2018/05/21	2019/05/21
☐	DC Power Supply	KEITHLEY	2303	1288003	2018/12/21	2019/12/21
☒	DC Power Supply	KEITHLEY	2303	000381E	2018/05/21	2019/05/21
☐	DC Power Supply	KEITHLEY	2303	000510E	2018/05/21	2019/05/21
☐	DC Power Supply	KEITHLEY	2303	1342896	2018/10/24	2019/10/24
☒	Temperature Chamber	WEISS	WKL64	562460029400 10	2018/12/13	2019/12/13
☐	Universal Radio Communication Tester	R&S	CMW500	159302	2018/07/23	2019/07/23
☐	Universal Radio Communication Tester	R&S	CMW500	126854	2018/07/23	2019/07/23
☒	Universal Radio Communication Tester	R&S	CMW500	164698	2018/06/17	2019/06/17
☒	Universal Radio Communication Tester	R&S	CMU200	110932	2018/4/27	2019/4/27
☐	Universal Radio Communication Tester	R&S	CMU200	123299	2018/11/23	2019/11/23
☐	Universal Radio Communication Tester	R&S	CMU200	117341	2018/12/09	2019/12/09
☐	Signal Analyzer	R&S	FSQ31	200021	2018/7/23	2019/7/23
☐	Signal Analyzer	R&S	FSU26	201069	2018/11/02	2019/11/02
☐	Spectrum Analyzer	Agilent	N9030A	MY51380032	2018/07/23	2019/07/23
☒	Spectrum Analyzer	Agilent	N9030A	MY49431698	2018/07/23	2019/07/23
☐	Spectrum Analyzer	Keysight	N9040B	MY57212529	2018/06/28	2019/06/28
☐	Signal generator	Agilent	E8257D	MY51500314	2018/04/27	2019/04/27
☒	Signal generator	Agilent	E8257D	MY49281095	2018/07/23	2019/07/23

☐	Vector Signal Generator	R&S	SMU200A	104162	2018/07/23	2019/07/23
☐	Vector Signal Generator	R&S	SMW200A	103447	2018/05/31	2019/05/31

☒ Main Test Equipments(RSE test system)						
Marked	Equipment Name	Manufacturer	Model	Serial Number	Cal Date	Cal-Due
☒	Universal Radio Communication Tester	R&S	CMU200	117385	2018/05/08	2019/05/07
☒	Universal Radio Communication Tester	R&S	MT8821C	6261760791	2018/04/02	2019/04/01
☒	Spectrum analyzer	R&S	FSU3	200474	2018/01/20	2019/01/19
☒	Spectrum analyzer	R&S	FSU43	100144	2018/01/20	2019/01/19
☐	Trilog Broadband Antenna (30M~3GHz)	SCHWARZBECK	VULB 9163	9163-490	2017/03/29	2019/03/28
☒	Trilog Broadband Antenna (30M~3GHz)	SCHWARZBECK	VULB 9163	9163-521	2018/04/09	2020/04/08
☒	Double-Ridged Waveguide Horn Antenna (1G~18GHz)	R&S	HF907	100304	2017/05/27	2019/05/26
☒	double ridged horn antenna（ 0.8G-18GHz)	R&S	HF907	100391	2017/7/20	2019/7/19
☒	Pyramidal Horn Antenna(18GHz-26.5 GHz)	ETS-Lindgren	3160-09	5140299	2017/07/20	2019/07/19
☐	Pyramidal Horn Antenna(18GHz-26.5 GHz)	ETS-Lindgren	3160-09	00206665	2018/4/21	2020/4/20
☒	Pyramidal Horn Antenna(26.5GHz-40 GHz)	ETS-Lindgren	3160-10	00205695	2018/04/20	2020/04/19
☐	Pyramidal Horn Antenna(26.5GHz-40 GHz)	ETS-Lindgren	3160-10	LM5947	2017/07/20	2019/07/19
☒	Measurement Software	R&S	EMC32 V8.40.0	/	/	/

6.1.2 Sub-contracted Test Location 1 :

Test Location 1:Main Test Equipments					
Equipment Name	Manufacturer	Model	Serial Number	Cal Date	Cal- Due
EMI Test Receiver&SA	Agilent	N9038A	N9038A	2018/8/30	2019/8/29
Loop Antenna	R&S	HFH2-Z2	HFH2-Z2	2018/5/30	2020/5/29
Bilog Antenna	TeseQ	CBL6112D	CBL6112D	2018/6/5	2019/6/4
LF Amplifier	Burgeon	BPA-530	BPA-530	2018/4/20	2019/4/19
Software Information					
Test Item	Software Name		Manufacturer		Version
RE	E3		AUDIX		6.2009-8-24(sporton)

7 Measurement Uncertainty

For a 95% confidence level (k = 2), the measurement expanded uncertainties for defined systems, in accordance with the recommendations of ISO 17025 as following:

Test Item		Extended Uncertainty
Transmit Output Power Conducted	Power [dBm]	U = 0.64 dB
RF Power Density, Conducted	Power [dBm]	U = 0.64 dB
Bandwidth	Magnitude [kHz]	200kHz: U＝9.06kHz 1.4MHz: U＝9.48kHz 3MHz: U＝10.86kHz 5MHz: U=13.84kHz 10MHz: U=22.32kHz 15MHz: U=31.9kHz 20MHz: U=41.78kHz
Band Edge Compliance	Disturbance Power [dBm]	U = 0.9 dB
Spurious Emissions, Conducted	Disturbance Power [dBm]	20MHz~3.6GHz：U＝0.88dB 3.6GHz~8.4GHz：U＝1.08dB 8.4GHz~13.6GHz：U＝1.24dB 13.6GHz~22GHz：U＝1.34dB 22GHz~26.5GHz：U＝1.36dB
Field Strength of Spurious Radiation	ERP/EIRP [dBm]	For 3 m Chamber: U = 5.94 dB (30 MHz to 3GHz) U = 5.54 dB (3GHz to 18GHz) U = 4.94 dB (18GHz to 26.5GHz)
Frequency Stability	Frequency Accuracy [Hz]	800MHz: U＝24.08Hz 900MHz: U＝24.54Hz 1900MHz: U＝34.7Hz 2100MHz: U=36.96Hz 2300MHz: U=39.24Hz 2500MHz: U=41.58Hz 2600MHz: U=42.74Hz

8 Appendixes

Appendix No.	Description
SYBH(Z-RF)20181011024001-2001-A	Appendix_for_GSM
SYBH(Z-RF)20181011024001-2001-B	Appendix_for_WCDMA
SYBH(Z-RF)20181011024001-2001-C	Appendix_for_LTE Band5
SYBH(Z-RF)20181011024001-2001-D	Appendix_for_LTE Band7

Appendix	Description
Appendix A	Effective (Isotropic) Radiated Power Output Data
Appendix B	Peak-Average Ratio
Appendix C	Modulation Characteristics
Appendix D	Bandwidth
Appendix E	Band Edges Compliance
Appendix F	Spurious Emission at Antenna Terminals
Appendix G	Field Strength of Spurious Radiation
Appendix H	Frequency Stability

END